

Is Now Part of



ON Semiconductor®

To learn more about ON Semiconductor, please visit our website at <u>www.onsemi.com</u>

Please note: As part of the Fairchild Semiconductor integration, some of the Fairchild orderable part numbers will need to change in order to meet ON Semiconductor's system requirements. Since the ON Semiconductor product management systems do not have the ability to manage part nomenclature that utilizes an underscore (_), the underscore (_) in the Fairchild part numbers will be changed to a dash (-). This document may contain device numbers with an underscore (_). Please check the ON Semiconductor website to verify the updated device numbers. The most current and up-to-date ordering information can be found at www.onsemi.com. Please email any questions regarding the system integration to Fairchild_questions@onsemi.com.

ON Semiconductor and the ON Semiconductor logo are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights of others. ON Semiconductor products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or unavteries, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out or i, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that ON Semiconductor was negligent regarding the design or manufacture of the part. ON Semiconductor and is officers, employees, uniotificated use, even if such claim any manner.



May 2015

FQD2P40

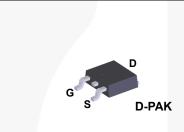
P-Channel QFET[®] MOSFET -400 V, -1.56 A, 6.5 Ω

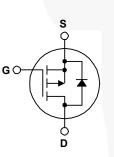
Description

This P-Channel enhancement mode power MOSFET is produced using Fairchild Semiconductor's proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state resistance, and to provide superior switching performance . Low Crss (Typ. 6.5 pF) and high avalanche energy strength. These devices are suitable for switched mode power supplies, audio amplifier, DC motor control, and variable switching power applications.. • RoHS Compliant

Features

- -1.56 A, -400 V, $R_{DS(on)}$ = 6.5 Ω (Max.) @ V_{GS} = -10 V, I_D = -0.78 A
- Low Gate Charge (Typ. 10 nC)
- 100% Avalanche Tested





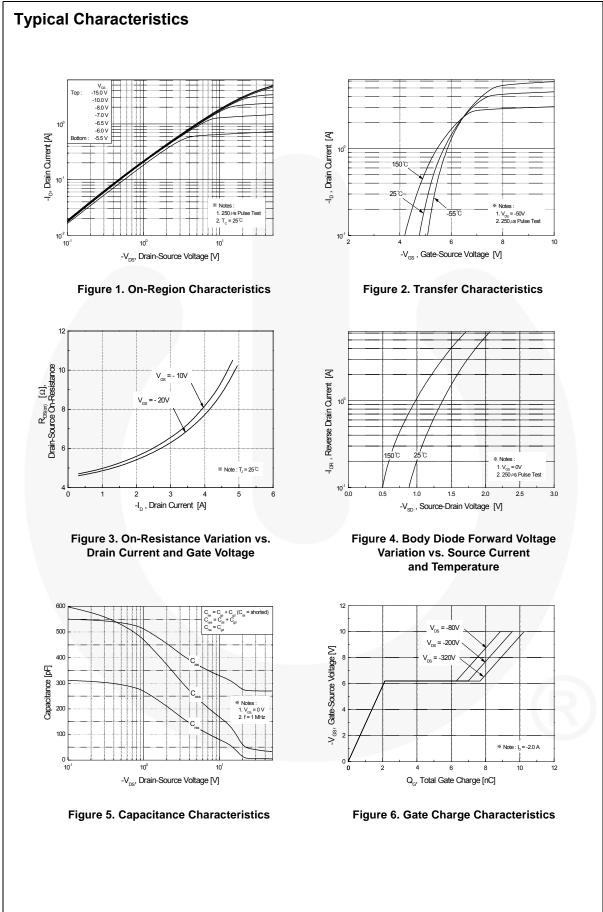
Absolute Maximum Ratings T_c = 25°C unless otherwise noted.

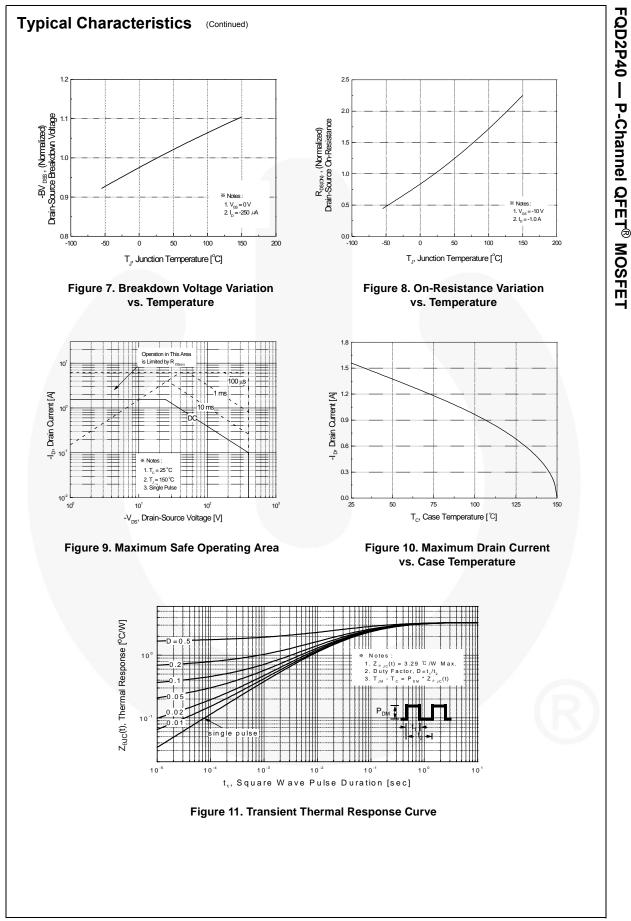
Symbol	Parameter		FQD2P40TM	Unit
V _{DSS}	Drain-Source Voltage		-400	V
I _D	Drain Current - Continuous ($T_C = 25^{\circ}C$)		-1.56	А
	- Continuous (T _C = 100°C)		-0.98	А
I _{DM}	Drain Current - Pulsed	(Note 1)	-6.24	A
V _{GSS}	Gate-Source Voltage		± 30	V
E _{AS}	Single Pulsed Avalanche Energy	(Note 2)	120	mJ
I _{AR}	Avalanche Current	(Note 1)	-1.56	A
E _{AR}	Repetitive Avalanche Energy	(Note 1)	3.8	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	-4.5	V/ns
P _D	Power Dissipation (T _A = 25°C) *		2.5	W
_	Power Dissipation ($T_C = 25^{\circ}C$)		38	W
	- Derate above 25°C		0.3	W/°C
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to +150	°C
TL	Maximum lead temperature for soldering, 1/8" from case for 5 seconds		300	°C

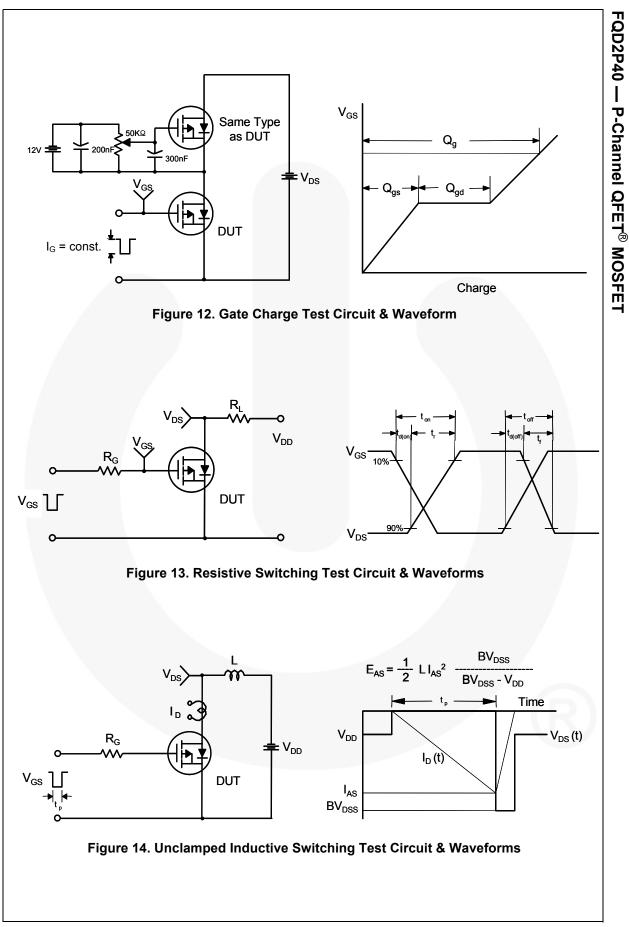
Thermal Characteristics

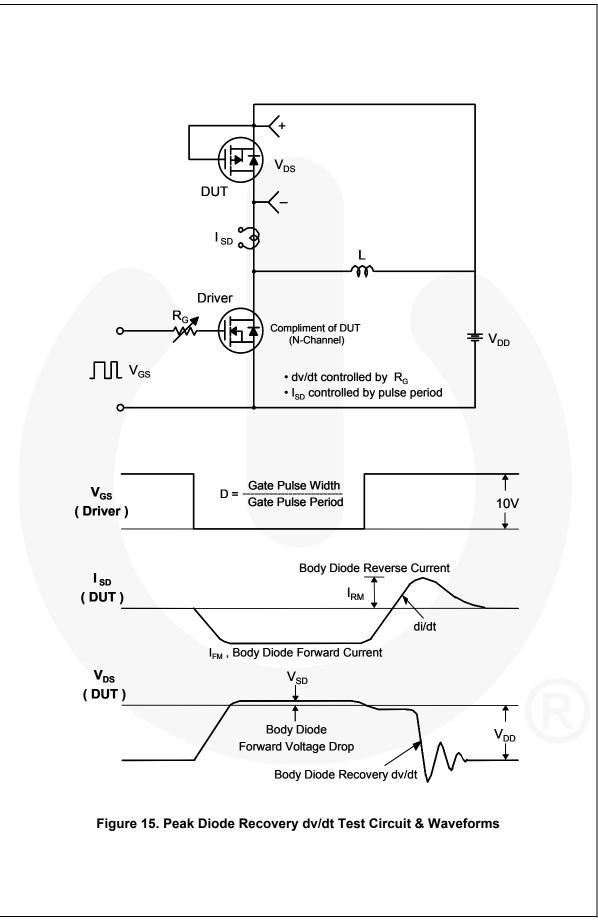
Symbol	Parameter	FQD2P40TM	Unit
R_{\thetaJC}	Thermal Resistance, Junction to Case, Max.	3.29	
D	Thermal Resistance, Junction to Ambient (Minimum Pad of 2-oz Copper), Max.	110	°C/W
R_{\thetaJA}	Thermal Resistance, Junction to Ambient (*1 in ² Pad of 2-oz Copper), Max.	50	

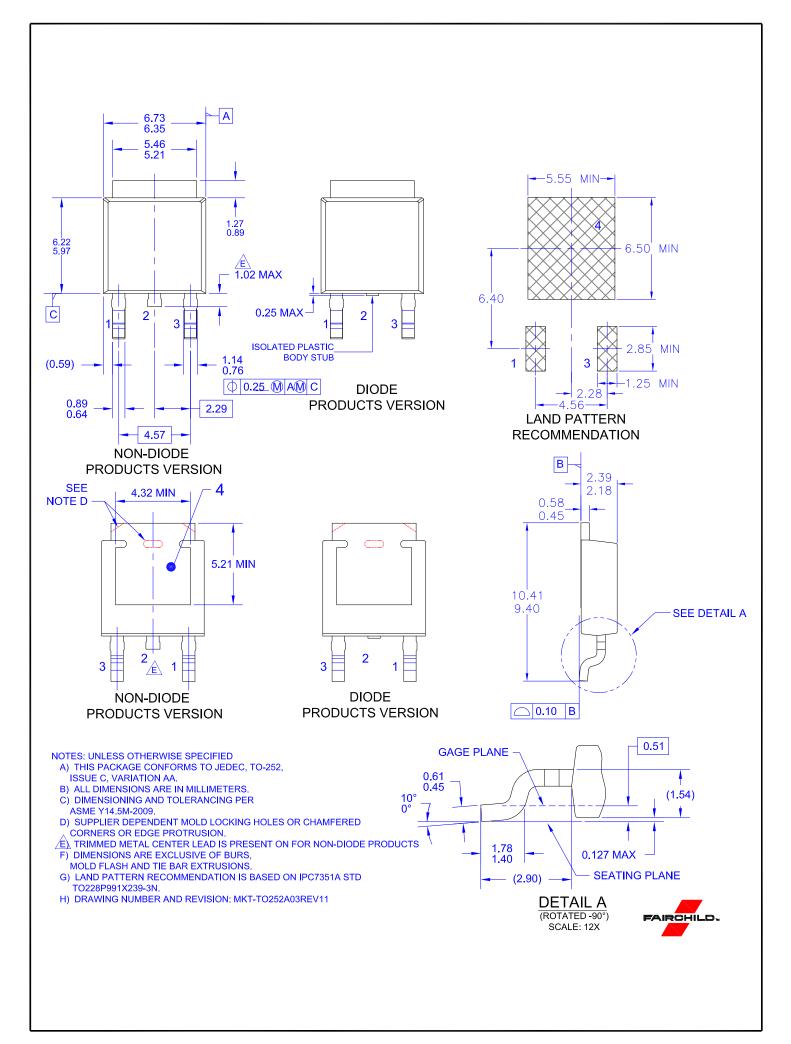
racteristi Drain-Sour Breakdowr Coefficient	ce Breakdown Volta	D-P T _C = 25°C		Tape an	d Reel	330 ו	nm	16 mr	n	000
racteristi Drain-Sour Breakdowr Coefficient	Parameter CS rce Breakdown Volta	T _C = 25°C	unless oth		PAK Tape and Reel 330			16 mm		2500 units
Drain-Sour Breakdowr Coefficient	cs ce Breakdown Volta			erwise noted.						
Drain-Sour Breakdowr Coefficient	cs ce Breakdown Volta			Test Cond	litions		Min.	Тур.	Max	. Unit
Drain-Sour Breakdowr Coefficient	ce Breakdown Volta							.,,,,,		
Breakdowr Coefficient		200	Voo =	0 V, I _D = -25	ΟΠΑ		-400			V
	Breakdown Voltage Temperature		$I_D = -250 \mu\text{A}$, Referenced to 25°C				-400	-		V/°C
Zero Gate			-	-400 V, V _{GS}					-1	μΑ
	Voltage Drain Curre	ent		-320 V, T _C =					-10	μΑ
Gate-Body	Leakage Current, F	orward	V _{GS} =	-30 V, V _{DS} =	• 0 V				-100	nA
	Leakage Current, F		V _{GS} =	30 V, V _{DS} =	0 V				100	nA
racteristi	cs									
			V _{DS} =	V _{GS} , I _D = -2	50 µA		-3.0		-5.0	V
								5.0	6.5	Ω
			V _{DS} =	-50 V, I _D = -0).78 A			1.26		S
			1					270	250	
			20	00	: 0 V,					pF
			f = 1.0	MHz						pF pF
	,	_		-	-2.0 A,			9	30	ns
Turn Off D			$R_{c} = 2$					33	75	ns
Turn-On D	elay Time	-	R _G = 2	.5 22				33 22	75 55	ns ns
Turn-Off Fa	,	_	. R _G = 2	.5 22	(Note 4)				
	all Time					Note 4)		22	55	ns
Turn-Off Fa	all Time Charge			-320 V, I _D =		Note 4)		22 25	55 60	ns
Turn-Off Fa Total Gate	all Time Charge ce Charge		V _{DS} =	-320 V, I _D =	-2.0 A,	Note 4) Note 4)		22 25 10	55 60 13	ns ns nC
Turn-Off Fa Total Gate Gate-Sour Gate-Drain	all Time Charge ce Charge o Charge	stics ar	V _{DS} = V _{GS} =	-320 V, I _D = -10 V	-2.0 A,			22 25 10 2.1	55 60 13 	ns ns nC nC
Turn-Off Fa Total Gate Gate-Sour Gate-Drain	all Time Charge ce Charge		V _{DS} = V _{GS} =	-320 V, I _D = -10 V kimum Ra	-2.0 A,			22 25 10 2.1	55 60 13 	ns ns nC nC nC
Turn-Off Fa Total Gate Gate-Sour Gate-Drain	all Time Charge ce Charge charge charge	ource Dic	V _{DS} = V _{GS} = nd Max	-320 V, I _D = -10 V kimum Ra rard Current	-2.0 A,			22 25 10 2.1 5.5	55 60 13 	ns ns nC nC nC
Turn-Off Fa Total Gate Gate-Sour Gate-Drair Ource Did Maximum Maximum	all Time Charge ce Charge n Charge ode Characteris Continuous Drain-S	ource Dic e Diode F	V _{DS} = V _{GS} = nd Max de Forw	-320 V, I _D = -10 V kimum Ra rard Current	-2.0 A, tings			22 25 10 2.1 5.5	55 60 13 	ns ns nC nC nC
Turn-Off Fa Total Gate Gate-Sour Gate-Drain Ource Did Maximum Maximum Drain-Sour	all Time Charge ce Charge d Charge ode Characteri s Continuous Drain-S Pulsed Drain-Sourc	ource Dic e Diode F	$V_{DS} =$ $V_{GS} =$ nd Max de Forw forward $V_{GS} =$	-320 V, I _D = -10 V kimum Ra rard Current Current	-2.0 A, htings		 	22 25 10 2.1 5.5	55 60 13 -1.56 -6.24	ns nC nC nC A A
	Gate Thres Static Drain On-Resista Forward Tr c Charac Input Capa Output Capa Reverse Tr ng Chara Turn-On D	racteristics Gate Threshold Voltage Static Drain-Source On-Resistance Forward Transconductance c Characteristics Input Capacitance Output Capacitance Reverse Transfer Capacitance ng Characteristics Turn-On Delay Time Turn-On Rise Time	Gate Threshold Voltage Static Drain-Source On-Resistance Forward Transconductance C Characteristics Input Capacitance Output Capacitance Reverse Transfer Capacitance ng Characteristics Turn-On Delay Time	Gate Threshold Voltage V _{DS} = Static Drain-Source V _{GS} = On-Resistance V _{DS} = Forward Transconductance V _{DS} = c Characteristics V _{DS} = Input Capacitance V _{DS} = Output Capacitance f = 1.0 Reverse Transfer Capacitance V _{DD} = Turn-On Delay Time V _{DD} =	Gate Threshold Voltage $V_{DS} = V_{GS}$, $I_D = -2i$ Static Drain-Source On-Resistance $V_{GS} = -10 \text{ V}$, $I_D = -4i$ Forward Transconductance $V_{DS} = -50 \text{ V}$, $I_D = -6i$ Forward Transconductance $V_{DS} = -50 \text{ V}$, $I_D = -6i$ C CharacteristicsInput CapacitanceOutput Capacitance $V_{DS} = -25 \text{ V}$, $V_{GS} = -25 \text{ V}$, $V_{GS} = -25 \text{ V}$ Reverse Transfer Capacitance $f = 1.0 \text{ MHz}$ ng CharacteristicsTurn-On Delay Time $V_{DD} = -200 \text{ V}$, $I_D = -200 \text{ V}$, $I_D = -200 \text{ V}$	Gate Threshold Voltage $V_{DS} = V_{GS}$, $I_D = -250 \ \mu A$ Static Drain-Source On-Resistance $V_{GS} = -10 \ V$, $I_D = -0.78 \ A$ Forward Transconductance $V_{DS} = -50 \ V$, $I_D = -0.78 \ A$ c Characteristics $V_{DS} = -50 \ V$, $I_D = -0.78 \ A$ Input Capacitance $V_{DS} = -25 \ V$, $V_{GS} = 0 \ V$, f = 1.0 MHzReverse Transfer Capacitance $f = 1.0 \ MHz$ num-On Delay Time $V_{DD} = -200 \ V$, $I_D = -2.0 \ A$,	Gate Threshold Voltage $V_{DS} = V_{GS}$, $I_D = -250 \ \mu A$ Static Drain-Source On-Resistance $V_{GS} = -10 \ V$, $I_D = -0.78 \ A$ Forward Transconductance $V_{DS} = -50 \ V$, $I_D = -0.78 \ A$ c Characteristics Input CapacitanceInput Capacitance $V_{DS} = -25 \ V$, $V_{GS} = 0 \ V$, f = 1.0 MHzReverse Transfer Capacitance $f = 1.0 \ MHz$ ng Characteristics Turn-On Delay TimeV_{DD} = -200 \ V, $I_D = -2.0 \ A$,	Gate Threshold Voltage $V_{DS} = V_{GS}$, $I_D = -250 \ \mu A$ -3.0Static Drain-Source On-Resistance $V_{GS} = -10 \ V$, $I_D = -0.78 \ A$ Forward Transconductance $V_{DS} = -50 \ V$, $I_D = -0.78 \ A$ c Characteristics $V_{DS} = -50 \ V$, $I_D = -0.78 \ A$ Input Capacitance $V_{DS} = -25 \ V$, $V_{GS} = 0 \ V$, f = 1.0 MHzReverse Transfer Capacitance $r = -25 \ V$, $V_{GS} = 0 \ V$, f = 1.0 MHz ng Characteristics Turn-On Delay Time $V_{DD} = -200 \ V$, $I_D = -2.0 \ A$,	Gate Threshold Voltage $V_{DS} = V_{GS}$, $I_D = -250 \ \mu A$ -3.0Static Drain-Source On-Resistance $V_{GS} = -10 \ V$, $I_D = -0.78 \ A$ 5.0Forward Transconductance $V_{DS} = -50 \ V$, $I_D = -0.78 \ A$ 1.26C CharacteristicsInput Capacitance $V_{DS} = -25 \ V$, $V_{GS} = 0 \ V$, f = 1.0 MHz270Output Capacitance $F = 1.0 \ MHz$ 6.5Input CapacitanceInput CapacitanceP and the second sec	Gate Threshold Voltage $V_{DS} = V_{GS}$, $I_D = -250 \ \mu A$ 3.05.0Static Drain-Source On-Resistance $V_{GS} = -10 \ V$, $I_D = -0.78 \ A$ 5.06.5Forward Transconductance $V_{DS} = -50 \ V$, $I_D = -0.78 \ A$ 1.26c CharacteristicsInput Capacitance $V_{DS} = -25 \ V$, $V_{GS} = 0 \ V$, f = 1.0 MHz270350Output Capacitancef = 1.0 \ MHz4560Reverse Transfer CapacitanceTurn-On Delay Time











ON Semiconductor and are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at <u>www.onsemi.com/site/pdf/Patent-Marking.pdf</u>. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by ON Semiconductor. "Typical" parameters which may be provided in ON Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights of others. ON Semiconductor products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor has against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death ass

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:

Literature Distribution Center for ON Semiconductor 19521 E. 32nd Pkwy, Aurora, Colorado 80011 USA Phone: 303-675-2175 or 800-344-3860 Toll Free USA/Canada Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada Email: orderlit@onsemi.com N. American Technical Support: 800–282–9855 Toll Free USA/Canada Europe, Middle East and Africa Technical Support: Phone: 421 33 790 2910

Japan Customer Focus Center Phone: 81-3-5817-1050 ON Semiconductor Website: www.onsemi.com

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your local Sales Representative

© Semiconductor Components Industries, LLC